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What Are <u>Embedded - Microcontrollers - Application Specific</u>?

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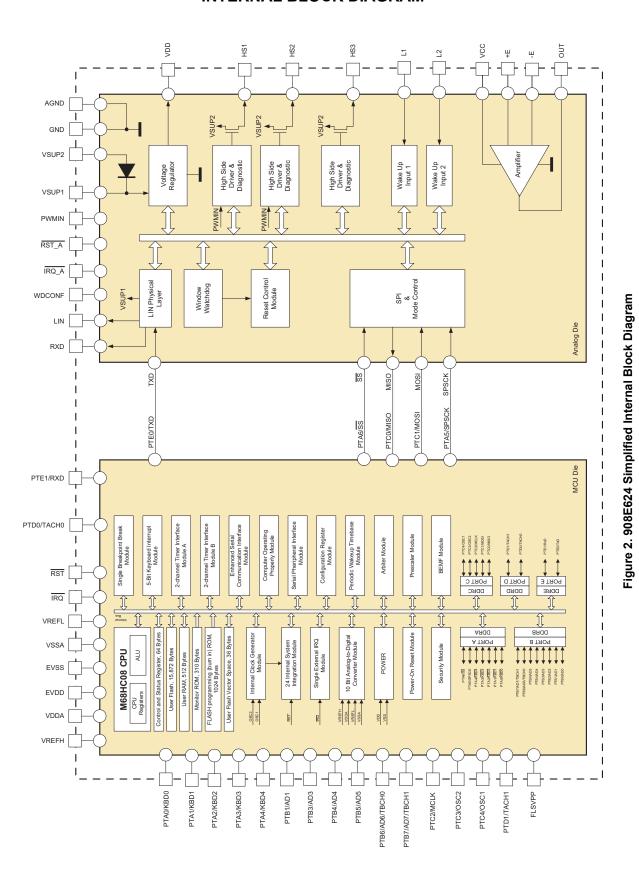
Details	
Product Status	Active
Applications	Automotive Mirror Control
Core Processor	HC08
Program Memory Type	FLASH (16kB)
Controller Series	908E
RAM Size	512 x 8
Interface	SCI, SPI
Number of I/O	16
Voltage - Supply	5.5V ~ 18V
Operating Temperature	-40°C ~ 125°C
Mounting Type	Surface Mount
Package / Case	54-BSSOP (0.295", 7.50mm Width)
Supplier Device Package	54-SOIC
Purchase URL	https://www.e-xfl.com/pro/item?MUrl=&PartUrl=mm908e624aypew

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong



INTERNAL BLOCK DIAGRAM



908E624



PIN CONNECTIONS

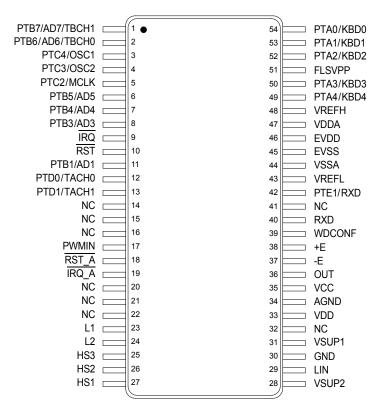


Figure 3. Pin Connections

Table 1. Pin Definitions

A functional description of each pin can be found in the Functional Pin Description section beginning on page 16.

Die	Pin	Pin Name	Formal Name	Definition
MCU	1 2 6 7 8 11	PTB7/AD7/TBCH1 PTB6/AD6/TBCH0 PTB5/AD5 PTB4/AD4 PTB3/AD3 PTB1/AD1	Port B I/Os	These pins are special function, bidirectional I/O port pins, that are shared with other functional modules in the MCU.
MCU	3 4 5	PTC4/OSC1 PTC3/OSC2 PTC2/MCLK	Port C I/Os	These pins are special function, bidirectional I/O port pins, that are shared with other functional modules in the MCU.
MCU	9	IRQ	External Interrupt Input	This pin is an asynchronous external interrupt input pin.
MCU	10	RST	External Reset	This pin is bidirectional, allowing a reset of the entire system. It is driven low when any internal reset source is asserted.
MCU	12 13	PTD0/TACH0 PTD1/TACH1	Port D I/Os	These pins are special function, bidirectional I/O port pins, that are shared with other functional modules in the MCU.
_	14, 15, 16, 20, 21, 22, 32, 41	NC	No Connect	Not connected.
MCU	42	PTE1/RXD	Port E I/O	This pin is a special function, bidirectional I/O port pin, that can is shared with other functional modules in the MCU.



Table 1. Pin Definitions (continued)

A functional description of each pin can be found in the Functional Pin Description section beginning on page 16.

Die	Pin	Pin Name	Formal Name	Definition
MCU	43 48	VREFL VREFH	ADC References	These pins are the reference voltage pins for the analog-to-digital converter (ADC).
MCU	44 47	VSSA VDDA	ADC Supply Pins	These pins are the power supply pins for the analog-to-digital converter.
MCU	45 46	EVSS EVDD	MCU Power Supply Pins	These pins are the ground and power supply pins, respectively. The MCU operates from a single power supply.
MCU	49 50 52 53 54	PTA4/KBD4 PTA3/KBD3 PTA2/KBD2 PTA1/KBD1 PTA0/KBD0	Port A I/Os	These pins are special function, bidirectional I/O port pins that are shared with other functional modules in the MCU.
MCU	51	FLSVPP	Test Pin	For test purposes only. Do not connect in the application.
Analog	17	PWMIN	Direct High Side Control Input	This pin allows the enabling and PWM control of the high side HS1 and HS2 pins.
Analog	18	RST_A	Internal Reset Output	This pin is the reset output pin of the analog die.
Analog	19	IRQ_A	Internal Interrupt Output	This pin is the interrupt output pin of the analog die indicating errors or wake-up events.
Analog	23 24	L1 L2	Wake-Up Inputs	These pins are the wake-up inputs of the analog chip.
Analog	25 26 27	HS3 HS2 HS1	High Side Output	These output pins are low $R_{DS(ON)}$ high side switches.
Analog	31 28	VSUP1 VSUP2	Power Supply Pins	These pins are device power supply pins.
Analog	29	LIN	LIN Bus	This pin represents the single-wire bus transmitter and receiver.
Analog	30 34	GND AGND	Power Ground Pins	These pins are device power ground connections.
Analog	33	VDD	Voltage Regulator Output	The +5.0 V voltage regulator output pin is intended to supply the embedded microcontroller.
Analog	35	VCC	Amplifier Power Supply	This pin is the single +5.0 V power supply for the current sense operational amplifier.
Analog	36	OUT	Amplifier Output	This pin is the output of the current sense operational amplifier.
Analog	37 38	-E +E	Amplifier Inputs	These pins are the current sense operational amplifier inverted and non-inverted inputs.
Analog	39	WDCONF	Window Watchdog Configuration Pin	This input pin is for configuration of the watchdog period and allows the disabling of the watchdog.
Analog	40	RXD	LIN Transceiver Output	This pin is the output of LIN transceiver.



STATIC ELECTRICAL CHARACTERISTICS

Table 3. Static Electrical Characteristics

All characteristics are for the analog chip only. Refer to the 68HC908EY16 data sheet for characteristics of the microcontroller chip. Characteristics noted under conditions 9.0 V \leq V_{SUP} \leq 16 V, -40 °C \leq T_J \leq 125 °C, unless otherwise noted. Typical values noted reflect the approximate parameter mean at T_A = 25 °C under nominal conditions, unless otherwise noted.

Characteristic	Symbol	Min	Тур	Max	Unit
SUPPLY VOLTAGE RANGE					
Nominal Operating Voltage	V _{SUP}	5.5	_	18	V
Functional Operating Voltage ⁽⁶⁾	V _{SUPOP}	_	_	27	V
SUPPLY CURRENT RANGE					
Normal Mode ⁽⁷⁾					
V _{SUP} = 13.5 V, Analog Chip in Normal Mode, MCU Operating Using Internal Oscillator at 32 MHz (8.0 MHz Bus Frequency), SPI, ESCI, ADC Enabled	1		20		mA
Stop Mode ^{(7), (8)}	I _{RUN}	_	20	_	IIIA
V _{SUP} = 13.5 V, LIN in recessive state Sleep Mode ⁽⁷⁾ , ⁽⁸⁾	I _{STOP}	_	60	75	μА
V _{SUP} = 13.5 V, LIN in recessive state	I _{SLEEP}	_	35	45	μА
DIGITAL INTERFACE RATINGS (ANALOG DIE)		I			1
Output Pin RST_A					
Low-state Output Voltage (I _{OUT} = -1.5 mA)	V_{OL}	_	_	0.4	V
High-state Output Current (V _{OUT} > 3.5 V)	I _{OH}	_	250	_	μА
Pull-down Current Limitation	I _{OL_MAX}	-1.5	_	-8.0	mA
Output Pin IRQ_A					V
Low-state Output Voltage (I _{OUT} = -1.5 mA)	V_{OL}	_	_	0.4	
High-state Output Voltage (I_{OUT} = 250 μ A)	V_{OH}	3.85	_	_	
Output Pin RXD					
Low-state Output Voltage (I _{OUT} = -1.5 mA)	V_{OL}	_		0.4	V
High-state Output Voltage (I _{OUT} = 250 μA)	V_{OH}	3.85		_	V
Capacitance (9)	C_{IN}	_	4.0	_	pF
Input Pin PWMIN					
Input Logic Low Voltage	V_{IL}	_	_	1.5	V
Input Logic High Voltage	V _{IH}	3.5	_	_	V
Input Current	I _{IN}	-10	_	10	μА
Capacitance (9)	C _{IN}	_	4.0	_	pF
Pin TXD, SS-Pull-up Current	I _{PU}	_	40	_	μА

- 6. Device is fully functional. All functions are operating. Over-temperature may occur.
- 7. Total current (I_{VSUP1} + I_{VSUP2}) measured at GND pin.
- 8. Stop and Sleep mode current will increase if $\rm V_{SUP}$ exceeds 15 V.
- 9. This parameter is guaranteed by process monitoring but is not production tested.



Table 3. Static Electrical Characteristics (continued)

All characteristics are for the analog chip only. Refer to the 68HC908EY16 data sheet for characteristics of the microcontroller chip. Characteristics noted under conditions 9.0 V \leq V $_{SUP}$ \leq 16 V, -40 $^{\circ}$ C \leq T $_{J}$ \leq 125 $^{\circ}$ C, unless otherwise noted. Typical values noted reflect the approximate parameter mean at T $_{A}$ = 25 $^{\circ}$ C under nominal conditions, unless otherwise noted.

Characteristic	Symbol	Min	Тур	Max	Unit
WINDOW WATCHDOG CONFIGURATION PIN (WDCONF)					•
External Resistor Range	R _{EXT}	10	_	100	kΩ
Watchdog Period Accuracy with External Resistor (Excluding Resistor Accuracy) (14)	WD _{CACC}	-15	_	15	%
LIN PHYSICAL LAYER					
LIN Transceiver Output Voltage					V
Recessive State, TXD HIGH, I_{OUT} = 1.0 μ A	V_{LIN_REC}	V _{SUP} -1	_	_	
Dominant State, TXD LOW, 500 Ω External Pull-up Resistor	V_{LIN_DOM}	_	_	1.4	
Normal Mode Pullup Resistor to VSUP	R _{PU}	20	30	60	kΩ
Stop, Sleep Mode Pull-up Current Source	I _{PU}	_	2.0	_	μА
Output Current Shutdown Threshold	I _{OV-CUR}	50	75	150	mA
Leakage Current to GND	I _{BUS}				μА
VSUP Disconnected, V _{BUS} at 18 V		_	1.0	10	
Recessive State, 8.0 V \leq V _{SUP} \leq 18 V, 8.0 V \leq V _{BUS} \leq 18 V, V _{BUS} \geq V _{SUP}		0.0	3.0	20	
GND Disconnected, V _{GND} = V _{SUP} , V _{BUS} at -18 V		-1.0	_	1.0	
LIN Receiver					V _{SUP}
Receiver Threshold Dominant	V _{BUS_DOM}	_	_	0.4	001
Receiver Threshold Recessive	V _{BUS_REC}	0.6	_	_	
Receiver Threshold Center	V _{BUS_CNT}	0.475	0.5	0.525	
Receiver Threshold Hysteresis	V _{BUS_HYS}	_	_	0.175	
HIGH SIDE OUTPUTS HS1 AND HS2		•		•	
Switch On Resistance	R _{DS(ON)}				Ω
T_J = 25 °C, I_{LOAD} = 150 mA, V_{SUP} > 9.0 V	, ,	_	2.0	2.5	
T_J = 125 °C, I_{LOAD} = 150 mA, V_{SUP} > 9.0 V		_	_	4.5	
T_J = 125 °C, I_{LOAD} = 120 mA, 5.5 V < V_{SUP} > 9.0 V		_	3.0	_	
Output Current Limit	I _{LIM}	300	_	600	mA
Over-temperature Shutdown (15), (16)	T _{HSSD}	155	_	190	°C
Leakage Current	I _{LEAK}	_	_	10	μА
Output Clamp Voltage	V _{CL}				V
I _{OUT} = -100 mA		-6.0	_	_	

- 14. Watchdog timing period calculation formula: P_{WD} = 0.991 * R_{EXT} + 0.648 (R_{EXT} in $k\Omega$ and P_{WD} in ms).
- 15. This parameter is guaranteed by process monitoring but it is not production tested
- 16. When over-temperature occurs, switch is turned off and latched off. Flag is set in SPI.



Table 3. Static Electrical Characteristics (continued)

All characteristics are for the analog chip only. Refer to the 68HC908EY16 data sheet for characteristics of the microcontroller chip. Characteristics noted under conditions 9.0 V \leq V_{SUP} \leq 16 V, -40 °C \leq T_J \leq 125 °C, unless otherwise noted. Typical values noted reflect the approximate parameter mean at T_A = 25°C under nominal conditions, unless otherwise noted.

Characteristic	Symbol	Min	Тур	Max	Unit
HIGH SIDE OUTPUT HS3	<u> </u>				
Switch On Resistance	R _{DS(ON)}				Ω
T_J = 25 °C, I_{LOAD} = 50 m A, V_{SUP} > 9.0 V	, ,	_	_	7.0	
T_J = 125 °C, I_{LOAD} = 50 mA, V_{SUP} > 9.0 V		_	_	10	
T_J = 125 °C, I_{LOAD} = 30 mA, 5.5 V < V_{SUP} > 9.0 V		_	_	14	
Output Current Limitation	I _{LIM}	60	100	200	mA
Over-temperature Shutdown (17), (18)	T _{HSSD}	155	_	190	°C
Leakage Current	I _{LEAK}	_	_	10	μА
CURRENT SENSE OPERATIONAL AMPLIFIER	•				
Rail-to-Rail Input Voltage	V _{IMC}	-0.1	_	V _{CC} +0.1	V
Output Voltage Range					V
Output Current ±1.0 mA	V _{OUT1}	0.1	_	V _{CC} -0.1	
Output Current ±5.0 mA	V _{OUT2}	0.3	_	V _{CC} -0.3	
Input Bias Current	I _B	_	_	250	nA
Input Offset Current	Io	-100	_	100	nA
Input Offset Voltage	V _{IO}	-25	_	25	mV
L1 AND L2 INPUTS	•				
Low Detection Threshold	V_{THL}				V
5.5 V < V _{SUP} < 6.0 V		2.0	2.5	3.0	
6.0 V < V _{SUP} < 18 V		2.5	3.0	3.5	
18 V < V _{SUP} < 27 V		2.7	3.2	3.7	
High Detection Threshold	V _{THH}				V
5.5 V < V _{SUP} < 6.0 V		2.7	3.3	3.8	
6.0 V < V _{SUP} < 18 V		3.0	4.0	4.5	
18 V < V _{SUP} < 27 V		3.5	4.2	4.7	
Hysteresis	V _{HYS}				V
5.5 V < V _{SUP} < 27 V		0.5	_	1.3	
Input Current	I _{IN}				μА
-0.2 V < V _{IN} < 40 V		-10	_	10	

- 17. This parameter is guaranteed by process monitoring but it is not production tested
- 18. When over-temperature occurs, switch is turned off and latched off. Flag is set in SPI.



Table 4. Dynamic Electrical Characteristics (continued)

All characteristics are for the analog chip only. Please refer to the 68HC908EY16 data sheet for characteristics of the microcontroller chip. Characteristics noted under conditions 9.0 V \leq V_{SUP} \leq 16 V, -40 °C \leq T_J \leq 125 °C, unless otherwise noted. Typical values noted reflect the approximate parameter mean at T_A = 25 °C under nominal conditions, unless otherwise noted.

Symbol	Min	Тур	Max	Unit
t _{OV-DELAY}	_	10	_	μS
				•
f _{SPIOP}	0.25	_	4.0	MHz
<u>'</u>		<u> </u>		
t _{WUF}	8.0	20	38	μS
. <u>l</u>				
t _{PWD}				ms
	_	10.558	_	
	_	99.748	_	
	97	150	205	
t _{RST}	0.65	1.0	1.35	ms
t _{INT}	7.0	10	13	μS
t _{NRTOUT}	97	150	205	ms
t _{S-HSON}	_	3.0	10	μS
t _{S-HSOFF}	_	3.0	10	μS
t _{S-NR2N}	6.0	35	70	μS
t _{W-SS}				μS
	15	40	80	
t _{W-SPI}				μS
	90	_	N/A	
t _{S-1STSPI}	30	_	N/A	μS
	tov-delay fspiop twuf tpwd trest tint tnrtout ts-hsoff ts-nr2n tw-ss tw-spi	tov-delay — fspiop 0.25 twuf 8.0 tpwd — ———————————————————————————————————	tov-delay — 10 fspiop 0.25 — twuf 8.0 20 tpwd — 10.558 — 99.748 97 150 trint 7.0 10 tnrout 97 150 ts-HSON — 3.0 ts-HSOFF — 3.0 ts-NR2N 6.0 35 tw-ss 15 40 tw-spi 90 —	tov-delay — 10 — fspiop 0.25 — 4.0 twuf 8.0 20 38 tpwd — 10.558 — — 99.748 — 97 150 205 tint 7.0 10 13 tntout 97 150 205 ts-hson — 3.0 10 ts-hsoff — 3.0 10 ts-hsoff — 3.0 10 tw-sis 15 40 80 tw-spi 90 — N/A

- 24. This parameter is guaranteed by process monitoring but is not production tested.
- 25. Delay between turn-on or turn-off command and high side on or high side off, excluding rise or fall time due to external load.
- 26. Delay between the end of the SPI command (rising edge of the SS) and start of device activation/deactivation.
- 27. This parameter is guaranteed by process monitoring but it is not production tested.
- 28. Also see Figure 10 on page 15



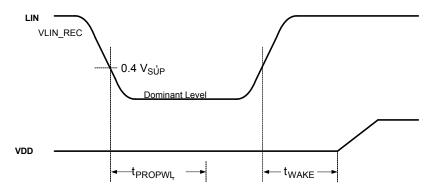


Figure 8. Wake-up Sleep Mode Timing

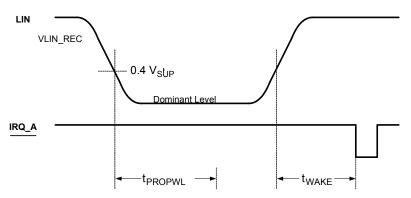


Figure 9. Wake-up Stop Mode Timing

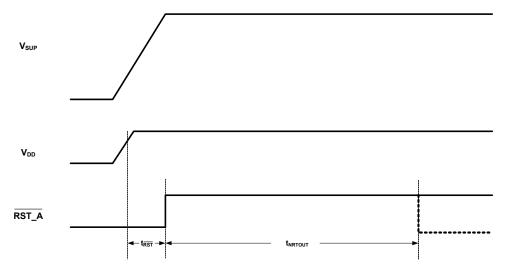


Figure 10. Power On Reset and Normal Request Timeout Timing



FUNCTIONAL DESCRIPTION

INTRODUCTION

The 908E624 was designed and developed as a highly integrated and cost-effective solution for automotive and industrial applications. For automotive body electronics, the 908E624 is well suited to perform relay control in applications like window lift, sunroof, etc., via a three-wire LIN bus.

The device combines an HC908EY16 MCU core with flash memory together with a *SmartMOS* IC chip. The *SmartMOS* IC chip combines power and control in one chip. Power switches are provided on the *SmartMOS* IC configured as

high side outputs. Other ports are also provided, which include a current sense operational amplifier port and two wake-up pins. An internal voltage regulator provides power to the MCU chip.

Also included in this device is a LIN physical layer, which communicates using a single wire. This enables this device to be compatible with three-wire bus systems, where one wire is used for communication, one for battery, and one for ground.

FUNCTIONAL PIN DESCRIPTION

See Figure 1, 908E624 Simplified Application Diagram, page 1, for a graphic representation of the various pins referred to in the following paragraphs. Also, see the pin diagram on page 3 for a depiction of the pin locations on the package.

PORT A I/O PINS (PTA0:4)

These pins are special function, bidirectional I/O port pins that are shared with other functional modules in the MCU. PTA0:PTA4 are shared with the keyboard interrupt pins KBD0:KBD4.

The PTA5/SPSCK pin is not accessible in this device and is internally connected to the SPI clock pin of the analog die. The PTA6/SS pin is likewise not accessible.

For details, refer to the 68HC908EY16 data sheet.

PORT B I/O PINS (PTB1:7)

These pins are special function, bidirectional I/O port pins that are shared with other functional modules in the MCU. All pins are shared with the ADC module. The PTB6: PTB7 pins are also shared with the Timer B module.

The PTB0/AD0 and PTB2/AD2 pins are not accessible in this device.

For details, refer to the 68HC908EY16 data sheet.

PORT C I/O PINS (PTC2:4)

These pins are special function, bidirectional I/O port pins that are shared with other functional modules in the MCU. For example, PTC2: PTC4 are shared with the ICG module.

PTC0/MISO and PTC1/MOSI are not accessible in this device and are internally connected to the MISO and MOSI SPI pins of the analog die.

For details, refer to the 68HC908EY16 data sheet.

PORT D I/O PINS (PTD:0:1)

PTD1/TACH1 and PTD0/TACH0/BEMF are special function, bidirectional I/O port pins that can also be programmed to be timer pins.

For details, refer to the 68HC908EY16 data sheet.

PORT E I/O PIN (PTE1)

PTE1/RXD and PTE0/TXD are special function, bidirectional I/O port pins that can also be programmed to be enhanced serial communication.

PTE0/TXD is internally connected to the TXD pin of the analog die. The connection for the receiver must be done externally.

For details, refer to the 68HC908EY16 data sheet.

EXTERNAL INTERRUPT PIN (IRQ)

The IRQ pin is an asynchronous external interrupt pin. This pin contains an internal pull-up resistor that is always activated, even when the IRQ pin is pulled LOW.

For details, refer to the 68HC908EY16 data sheet.

EXTERNAL RESET PIN (RST)

A logic [0] on the $\overline{\text{RST}}$ pin forces the MCU to a known startup state. It is driven LOW when any internal reset source is asserted.

This pin contains an internal pull-up resistor that is always activated, even when the reset pin is pulled LOW.

Important To ensure proper operation, do not add any external pull-up resistor.

For details, refer to the 68HC908EY16 data sheet.

MCU POWER SUPPLY PINS (EVDD AND EVSS)

EVDD and EVSS are the power supply and ground pins, respectively. The MCU operates from a single power supply.

Fast signal transitions on MCU pins place high, short duration current demands on the power supply. To prevent noise problems, take special care to provide power supply bypassing at the MCU.

For details, refer to the 68HC908EY16 data sheet.



ADC SUPPLY PINS (VDDA AND VSSA)

VDDA and VSSA are the power supply pins for the analogto-digital converter (ADC). It is recommended that a highquality ceramic decoupling capacitor be placed between these pins.

Important VDDA is the supply for the ADC and should be tied to the same potential as EVDD via separate traces. VSSA is the ground pin for the ADC and should be tied to the same potential as EVSS via separate traces.

For details, refer to the 68HC908EY16 data sheet.

ADC REFERENCE PINS (VREFL AND VREFH)

VREFL and VREFH are the reference voltage pins for the ADC. It is recommended that a high quality ceramic decoupling capacitor be placed between these pins.

Important VREFH is the high reference supply for the ADC and should be tied to the same potential as VDDA via separate traces. VREFL is the low reference supply for the ADC and should be tied to the same potential as VSSA via separate traces.

For details, refer to the 68HC908EY16 data sheet.

TEST PIN (FLSVPP)

This pin is for test purposes only. Do not connect in the application or connect to GND.

PWMIN PIN (PWMIN)

This pin is the direct PWM input for high side outputs 1 and 2 (HS1 and HS2). If no PWM control is required, PWMIN must be connected to VDD to enable the HS1 and HS2 outputs.

LIN TRANSCEIVER OUTPUT PIN (RXD)

This pin is the output of LIN transceiver. The pin must be connected to the microcontroller's Enhanced Serial Communications Interface (ESCI) module (RXD pin).

RESET PIN (RST A)

RST_A is the reset output pin of the analog die and must be connected to the RST pin of the MCU.

Important To ensure proper operation, do not add any external pull-up resistor.

INTERRUPT PIN (IRQ A)

IRQ_A is the interrupt output pin of the analog die indicating errors or wake-up events. This pin must be connected to the IRQ pin of the MCU.

WINDOW WATCHDOG CONFIGURATION PIN (WDCONF)

This pin is the configuration pin for the internal watchdog. A resistor is connected to this pin. The resistor value defines

the watchdog period. If the pin is open, the watchdog period is fixed to its default value.

The watchdog can be disabled (e.g., for flash programming or software debugging) by connecting this pin to GND.

POWER SUPPLY PINS (VSUP1 AND VSUP2)

This VSUP1 power supply pin supplies the voltage regulator, the internal logic, and LIN transceiver.

This VSUP2 power supply pin is the positive supply for the high side switches.

POWER GROUND PIN (GND)

This pin is the device ground connection.

HIGH SIDE OUTPUT PINS (HS1 AND HS2)

These pins are high side switch outputs to drive loads such as relays or lamps. Each switch is protected with over-temperature and current limit (over-current). The output has an internal clamp circuitry for inductive load. The HS1 and HS2 outputs are controlled by the SPI and have a direct enabled input (PWMIN) for PWM capability.

HIGH SIDE OUTPUT PIN (HS3)

This high side switch can be used to drive small lamps, Hall-effect sensors, or switch pull-up resistors. The switch is protected with over-temperature and current limit (over-current). The output is controlled only by the SPI.

LIN BUS PIN (LIN)

The LIN pin represents the single-wire bus transmitter and receiver. It is suited for automotive bus systems and is based on the LIN bus specification.

WAKE-UP PINS (L1 AND L2)

These pins are high-voltage capable inputs used to sense external switches and to wake-up the device from Sleep or Stop mode. During Normal mode the state of these pins can be read through the SPI.

Important If unused, these pins should be connected to VSUP or GND to avoid parasitic transitions. In Low Power Mode, this could lead to random wake-up events.

CURRENT SENSE OPERATIONAL AMPLIFIER PINS (E+, E-, OUT, VCC)

These are the pins of the single supply current sense operational amplifier.

- The E+ and E- input pins are the non-inverting and inverting inputs of the current sense operational amplifier, respectively.
- The OUT pin is the output pin of the current sense operational amplifier.
- The VCC pin is the +5.0 V single supply connection.



FUNCTIONAL DEVICE OPERATION

OPERATIONAL MODES

908E624 ANALOG DIE MODES OF OPERATION

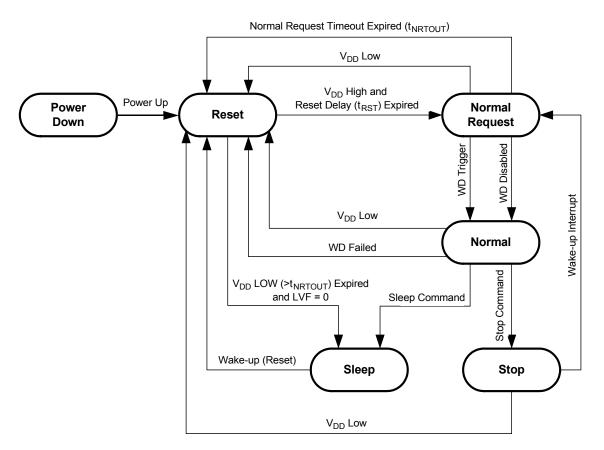
The 908E624 offers three operating modes: Normal (Run), Stop, and Sleep. In Normal mode the device is active and is operating under normal application conditions. The Stop and Sleep modes are low-power modes with wake-up capabilities.

In Stop mode, the voltage regulator still supplies the MCU with V_{DD} (limited current capability), and in Sleep mode the voltage regulator is turned off (V_{DD} = 0 V).

Wake-up from Stop mode is initiated by a wake-up interrupt. Wake-up from Sleep mode is done by a reset and the voltage regulator is turned back on.

The selection of the different modes is controlled by the MODE1:2 bits in the SPI Control register.

<u>Figure 11</u> describes how transitions are done between the different operating modes and <u>Table 6</u>, page <u>20</u>, gives an overview of the operating mode.



Legend

WD: Watchdog

WD Disabled: Watchdog disabled (WDCONF pin connected to GND)

WD Trigger: Watchdog is triggered by SPI command

WD Failed: No watchdog trigger or trigger occurs in closed window

Stop Command: Stop command sent via SPI

Sleep Command: Sleep command sent via SPI

Wake-up: L1 or L2 state change or LIN bus wake-up or SS rising edge

Figure 11. Operating Modes and Transitions



Table 6. Operating Modes Overview

Device Mode	Voltage Regulator	Wake-up Capabilities	RST_A Output	Watchdog Function	HS1, HS2, and HS3	LIN Interface	Sense Amplifier
Reset	V _{DD} ON	N/A	LOW	Disabled	Disabled	Recessive only	Not active
Normal Request	V _{DD} ON	N/A	HIGH	150 ms time out if WD enabled	Enabled	Transmit and receive	Not active
Normal (Run)	V _{DD} ON	N/A	HIGH	Window WD if enabled	Enabled	Transmit and receive	Active
Stop	V _{DD} ON with limited current capability	LIN wake-up, L1, L2 state change, SS rising edge	HIGH	Disabled	Disabled	Recessive state with wake-up capability	Not active
Sleep	V _{DD} OFF	LIN wake-up L1, L2 state change	LOW	Disabled	Disabled	Recessive state with wake-up capability	Not active

INTERRUPTS

In Normal (Run) mode the 908E624 has four different interrupt sources. An interrupt pulse on the $\overline{IRQ_A}$ pin is generated to report a fault to the MCU. All interrupts are not maskable and cannot be disabled.

After an Interrupt the INTSRC bit in the SPI Status register is set, indicating the source of the event. This interrupt source information is only transferred once, and the INTSRC bit is cleared automatically.

Low-Voltage Interrupt

Low-voltage interrupt (LVI) is related to external supply voltage VSUP1. If this voltage falls below the LVI threshold, it will set the LVF bit in the SPI Status register and an interrupt will be initiated. The LVF bit remains set as long as the Low-voltage condition is present.

During Sleep and Stop mode the low-voltage interrupt circuitry is disabled.

High-voltage Interrupt

High-voltage interrupt (HVI) is related to external supply voltage VSUP1. If this voltage rises above the HVI threshold, it will set the HVF bit in the SPI Status register and an interrupt will be initiated. The HVF bit remains set as long as the high-voltage condition is present.

During Sleep and Stop mode the high-voltage interrupt circuitry is disabled.

Wake-up Interrupts

In Stop mode the $\overline{IRQ_A}$ pin reports wake-up events on the L1, L2, or the LIN bus to the MCU. All wake-up interrupts are not maskable and cannot be disabled.

After a wake-up interrupt, the INTSRC bit in the Serial Peripheral Interface (SPI) Status register is set, indicating the source of the event. This wake-up source information is only transferred once, and the INTSRC bit is cleared automatically.

Figure 12, page 21, describes the Stop/Wake-up procedure.

Voltage Regulator Temperature Prewarning (VDDT)

Voltage regulator temperature prewarning (VDDT) is generated if the voltage regulator temperature is above the T_{PRE} threshold. It will set the VDDT bit in the SPI Status register and an interrupt will be initiated. The VDDT bit remains set as long as the error condition is present.

During Sleep and Stop mode the voltage regulator temperature prewarning circuitry is disabled.

High Side Switch Thermal Shutdown (HSST)

The high side switch thermal shutdown HSST is generated if one of the high side switches HS1:HS3 is above the HSST threshold, it will shutdown all high side switches, set the HSST flag in the SPI Status register and an interrupt will be initiated. The HSST bit remains set as long as the error condition is present.

During Sleep and Stop mode the high side switch thermal shutdown circuitry is disabled.



The LIN pin offers high susceptibility immunity level from external disturbance, guaranteeing communication during external disturbance.

The LIN transmitter circuitry is enabled in Normal and Normal Request mode.

An over-current condition (e.g. LIN bus short to V_{BAT}) or a over-temperature in the output low side FET will shutdown

the transmitter and set the LINFAIL flag in the SPI Status Register.

For improved performance and safe behavior in case of LIN bus short to Ground or LIN bus leakage during low power mode the internal pull-up resistor on the LIN pin can be disconnected, with the LIN-PU bit in the SPI Control Register, and a small current source keeps the LIN bus at recessive level. In case of a LIN bus short to GND, this feature will reduce the current consumption in STOP and SLEEP modes.

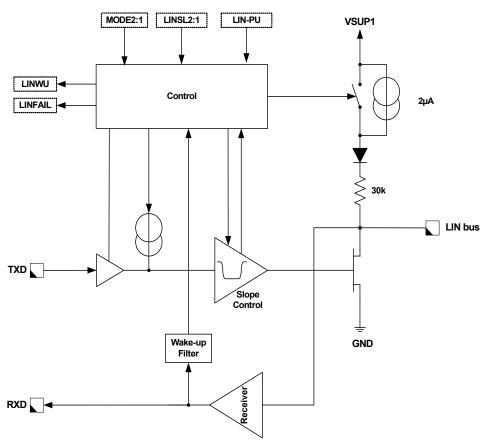


Figure 15. LIN Interface

TXD Pin

The TXD pin is the MCU interface to control the state of the LIN transmitter (see Figure 2, page 2). When TXD is LOW, the LIN pin is low (dominant state). When TXD is HIGH, the LIN output MOSFET is turned off (recessive state). The TXD pin has an internal pull-up current source in order to set the LIN bus to recessive state in the event, for instance, the microcontroller could not control it during system power-up or power-down.

RXD Pin

The RXD transceiver pin is the MCU interface, which reports the state of the LIN bus voltage. LIN HIGH (recessive state) is reported by a high level on RXD, LIN LOW (dominant state) by a low level on RXD.

STOP Mode and Wake-up Feature

During STOP mode operation the transmitter of the physical layer is disabled. In case the bit LIN-PU was set in the Stop mode sequence the internal pull-up resistor is disconnected from VSUP and a small current source keeps the LIN pin in recessive state. The receiver is still active and able to detect wake-up events on the LIN bus line.

A dominant level longer than t_{PROPWL} followed by an rising edge will generate a wake-up interrupt and set the LINWF flag in the SPI Status Register. Also see Figure 9, page 15.

SLEEP Mode and Wake-up Feature

During SLEEP mode operation the transmitter of the physical layer is disabled. In case the bit LIN-PU was set in the Sleep mode sequence the internal pull-up resistor is

disconnected from VSUP and a small current source keeps the LIN pin in recessive state. The receiver is still active to be able to detect wake-up events on the LIN bus line.

A dominant level longer than t_{PROPWL} followed by an rising edge will generate a system wake-up (reset) and set the LINWF flag in the SPI Status Register. Also see <u>Figure 8</u>, page <u>15</u>).

WINDOW WATCHDOG

The window watchdog is configurable using an external resistor at the WDCONF pin. The watchdog is cleared through by the MODE1:2 bits in the SPI Control register (refer to Table 8, page 26).

A watchdog clear is only allowed in the open window. If the watchdog is cleared in the closed window or has not been cleared at the end of the <u>open</u> window, the watchdog will generate a reset on the <u>RST_A</u> pin and reset the whole device.

Note The watchdog clear in Normal request mode (150 ms) (first watchdog clear) has no window.

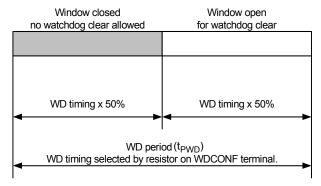


Figure 16. Window Watchdog Operation

Watchdog Configuration

If the WDCONF pin is left open, the default watchdog period is selected (typ. 150 ms). If no watchdog function is required, the WDCONF pin must be connected to GND.

The watchdog period is calculated using the following formula:

 t_{PWD} [ms] = 0.991 * R_{FXT} [k Ω] + 0.648

VOLTAGE REGULATOR

The 908E624 chip contains a low-power, low dropout voltage regulator to provide internal power and external power for the MCU. The on-chip regulator consist of two elements, the main voltage regulator and the low-voltage reset circuit.

The V_{DD} regulator accepts an unregulated input supply and provides a regulated V_{DD} supply to all digital sections of the device. The output of the regulator is also connected to the VDD pin to provide the 5.0 V to the microcontroller.

Current Limit (Over-current) Protection

The voltage regulator has current limit to protect the device against over-current and short-circuit conditions.

Over-temperature Protection

The voltage regulator also features an over-temperature protection having an over-temperature warning (Interrupt - VDDT) and an over-temperature shutdown.

Stop Mode

During Stop mode, the Stop mode regulator supplies a regulated output voltage. The Stop mode regulator has a limited output current capability.

Sleep Mode

In Sleep mode the voltage regulator external V_{DD} is turned off

FACTORY TRIMMING AND CALIBRATION

To enhance the ease of use of the 908E624, various parameters (e.g., ICG trim value) are stored in the flash memory of the device. The following flash memory locations are reserved for this purpose and might have a value different from the "empty" (0xFF) state:

- 0xFD80:0xFDDF Trim and Calibration Values
- 0xFFFE:0xFFFF Reset Vector

In the event the application uses these parameters, one has to take care not to erase or override these values. If these parameters are not used, these flash locations can be erased and otherwise used.

Trim Values

The usage of the trim values, located in the flash memory, is explained in the following.

Internal Clock Generator (ICG) Trim Value

The internal clock generator (ICG) module is used to create a stable clock source for the microcontroller without using any external components. The untrimmed frequency of the low frequency base clock (IBASE), will vary as much as $\pm 25\%$, due to process, temperature, and voltage dependencies. To compensate for these dependencies, an ICG trim value is located at the address \$FDC2. After trimming the ICG, a range of typ. $\pm 2\%$ ($\pm 3\%$ max.) at nominal conditions (filtered (100 nF) and stabilized (4.7 μ F) V_{DD} = 5.0 V, $T_{Ambient} \sim 23$ °C) and will vary over-temperature and voltage (V_{DD}) as indicated in the 68HC908EY16 data sheet.

To trim the ICG, these values must be copied to the ICG Trim Register ICGTR at address \$38 of the MCU.

Important The value has to be copied after every reset.

OPERATING MODES OF THE MCU

For a detailed description of the operating modes of the MCU, refer to the MC68HC908EY16 data sheet.

Table 7. SPI Register Overview

Read/Write	Bit								
Information	D7	D6	D5	D4	D3	D2	D1	D0	
Write	LINSL2	LINSL1	LIN-PU	HS3ON	HS2ON	HS10N	MODE2	MODE1	
Read	INTSRC (30)	LINWU or LINFAIL	HVF	LVF or BATFAIL (31)	VDDT	HSST	L2	L1	
Write Reset Value	0	0	0	0	0	0	_	_	
Write Reset Condition	POR, RESET	POR, RESET	POR	POR, RESET	POR, RESET	POR, RESET	_	_	

Notes

- 30. D7 signals interrupts and wake-up interrupts, D6:D0 indicated the source.
- 31. The first SPI read after reset returns the BATFAIL flag state on bit D4.

SPI Control Register (Write)

<u>Table 8</u> shows the SPI Control register bits by name.

Table 8. Control Bits Function (Write Operation)

D7	D6	D5	D4	D3	D2	D1	D0
LINSL2	LINSL1	LIN-PU	HS3ON	HS2ON	HS10N	MODE2	MODE1

LINSL2:1—LIN Baud Rate and Low-power Mode Selection Bits

These bits select the LIN slew rate and requested low-power mode in accordance with <u>Table 9</u>. Reset clears the LINSL2:1 bits.

Table 9. LIN Baud Rate and Low-power Mode Selection Bits

LINSL2	LINSL1	Description
0	0	Baud Rate up to 20 kbps (normal)
0	1	Baud Rate up to 10 kbps (slow)
1	0	Fast Program Download Baud Rate up to 100 kbps
1	1	Low-power Mode (Sleep or Stop) Request

LIN-PU-LIN Pull-up Enable Bit

This bit controls the LIN pull-up resistor during Sleep and Stop modes.

- 1 = Pull-up disconnected in Sleep and Stop modes.
- 0 = Pull-up connected in Sleep and Stop modes.

If the Pull-up is disconnected, a small current source is used to pull the LIN pin in recessive state. In case of an erroneous short of the LIN bus to ground, this will significantly

reduce the power consumption, e.g. in combination with STOP/SLEEP mode.

HS3ON: HS1ON—High Side H3: HS1 Enable Bits

These bits enable the HSx. Reset clears the HSxON bit.

- 1 = HSx switched on (refer to Note below).
- 0 = HSx switched off.

Note If no PWM on HS1 and HS2 is required, the PWMIN pin must be connected to the VDD pin.

MODE2:1-Mode Section Bits

The MODE2:1 bits control the operating modes and the watchdog in accordance with <u>Table 10</u>.

Table 10. Mode Selection Bits

MODE2	MODE1	Description			
0	0	Sleep Mode (32)			
0	1	Stop Mode (32)			
1	0	Watchdog Clear (33)			
1	1	Run (Normal) Mode			

Notes

- To enter Sleep and Stop mode, a special sequence of SPI commands is implemented.
- 33. The device stays in Run (Normal) mode.

To safely enter Sleep or Stop mode and to ensure that these modes are not affected by noise issue during SPI transmission, the Sleep/Stop commands require two SPI transmissions.

Sleep Mode Sequence

The Sleep command, as shown in $\underline{\text{Table 11}}$, must be sent twice.

Table 11. Sleep Command Bits

LINSL2	LINSL1	LIN-PU	HS3ON	HS2ON	HS10N	MODE2	MODE1
1	1	0/1	0	0	0	0	0



PCB Level Programming

If the IC is soldered onto the PCB board, it is typically not possible to separately power the MCU with +5.0 V, the whole

system has to be powered up providing V_{SUP} (see Figure 19).

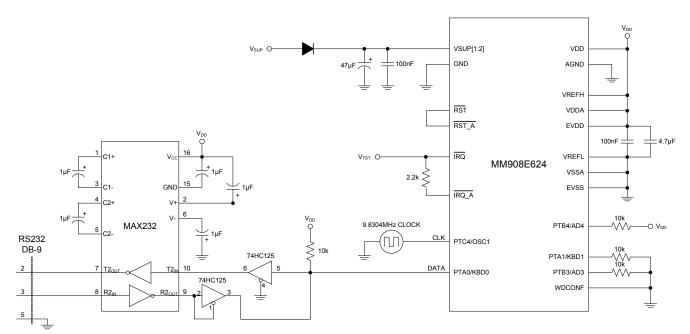


Figure 19. Normal Monitor Mode Circuit

<u>Table 14</u> summarizes the possible configurations and the necessary setups.

Table 14. Monitor Mode Signal Requirements and Options

			T WDCONF	Reset Vector	Serial Communication		Mode Selection				Normal	Communication Speed			
Mode	IRQ	RST			РТА0	PTA1	РТВ3	PTB4	ICG CO	COP	COP Request Timeout	External Clock	Bus Frequenc y	Baud Rate	
Normal Monitor	V _{TST}	V _{DD}	GND	х	1	0	0	1	OFF	disabled	disabled	9.8304 MHz	2.4576 MHz	9600	
Forced	V _{DD}	V _{DD}	GND	\$FFFF (blank)	1	0	×	x x	OFF	disabled	disabled	9.8304 MHz	2.4576 MHz	9600	
Monitor	GND							^	^	*	Χ	Х	Х	^	ON
User	V _{DD}	V _{DD}	R _{EXT}	not \$FFFF (not blank)	Х	Х	Х	Х	ON	enabled	enabled	_	Nominal 1.6 MHz	Nominal 6300	

- 34. PTA0 must have a pull-up resistor to $V_{\mbox{\scriptsize DD}}$ in monitor mode.
- 35. External clock is a 4.9152 MHz, 9.8304 MHz or 19.6608 MHz canned oscillator on OCS1.
- 36. Communication speed with external clock is depending on external clock value. Baud rate is bus frequency / 256.
- 37. X = don't care.
- 38. V_{TST} is a high voltage V_{DD} + 3.5 V \leq $V_{TST} \leq$ V_{DD} + 4.5 V.



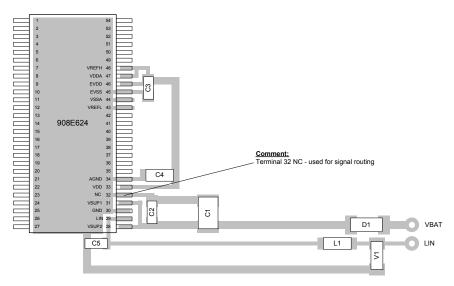


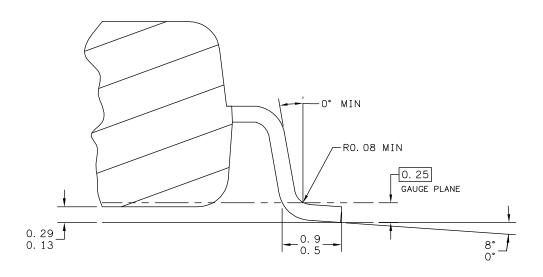
Figure 21. PCB Layout Recommendations

Table 15. Component Value Recommendation

Component	Recommended Value ⁽³⁹⁾	Comments / Signal routing
D1		Reverse battery protection
C1	Bulk Capacitor	
C2	100 nF, SMD Ceramic	Close (<5.0 mm) to VSUP1, VSUP2 pins with good ground return
C3	100 nF, SMD Ceramic	Close (<3.0 mm) to digital supply pins (EVDD, EVSS) with good ground return.
		The positive analog (VREFH, VDDA) and the digital (EVDD) supply should be connected right at the C3.
C4	4.7 μF, SMD Ceramic or Low ESR	Bulk Capacitor
C5	180 pF, SMD Ceramic	Close (<5.0 mm) to LIN pin.
		Total Capacitance per LIN node has to be below 220 pF.
		$(C_{TOTAL} = C_{LIN-PIN} + C5 + C_{VARISTOR} \sim 10 \text{ pF} + 180 \text{ pF} + 15 \text{ pF})$
V1 ⁽⁴⁰⁾	Varistor Type TDK AVR-M1608C270MBAAB	Optional (close to LIN connector)
L1 ⁽⁴⁰⁾	SMD Ferrite Bead Type TDK MMZ2012Y202B	Optional, (close to LIN connector)

- 39. Freescale does not assume liability, endorse, or want components from external manufactures that are referenced in circuit drawings or tables. While Freescale offers component recommendations in this configuration, it is the customer's responsibility to validate their application.
- 40. Components are recommended to improve EMC and ESD performance.





SECTION B-B

© FREESCALE SEMICONDUCTOR, INC. ALL RIGHTS RESERVED.	MECHANICA	L OUTLINE	PRINT VERSION NOT TO SCAL		
TITLE:	PITCH	DOCUMENT NO	REV: B		
54LD SOIC W/B, 0.65		CASE NUMBER: 1365-01		12 APR 2005	
CASE-00TETNE		STANDARD: NO	N-JEDEC		

EW SUFFIX (Pb-FREE) 54-Pin SOIC WIDE BODY 98ASA99294D ISSUE B

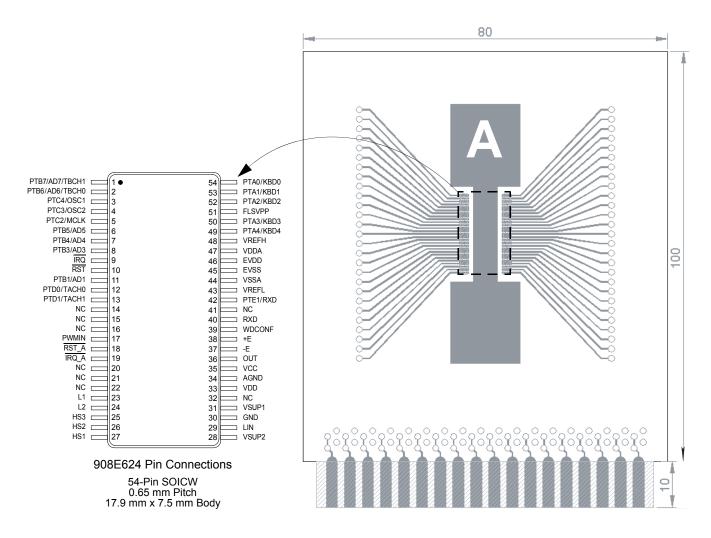


Figure 22. Surface Mount for SOIC Wide Body Non-exposed Pad

Device on Thermal Test Board

Material: Single layer printed circuit board

FR4, 1.6 mm thickness

Cu traces, 0.07 mm thickness

Outline: 80 mm x 100 mm board area,

including edge connector for thermal

testing

Area A: Cu heat-spreading areas on board

surface

Ambient Conditions: Natural convection, still air

Table 17. Thermal Resistance Performance

Pin	Pin Area A 1 = Power Chip, 2 = Lo			gic Chip (°C/W)		
Resistance	(mm²)	m = 1, n = 1	m = 1, n = 2 m = 2, n = 1	m = 2, n = 2		
$R_{\theta JAmn}$	0	58	48	53		
	300	56	46	51		
	600	54	45	50		

 $R_{\theta JA\textit{mn}}$ is the thermal resistance between die junction and ambient air.

This device is a dual die package. Index m indicates the die that is heated. Index n refers to the number of the die where the junction temperature is sensed.



REVISION HISTORY

REVISION	DATE	DESCRIPTION OF CHANGES
7.0	5/2006	Implemented Revision History page
		Added Pb-Free package option (Suffix EW) and higher Soldering temperature
		 Added "Y" temperature (T_J-40°C to 125°C) code option (MM908E624AYEW) and updated condition statement for Static and Dynamic Electrical Characteristics
		 Corrected <u>Figure 11</u>, <u>Operating Modes and Transitions</u> ("STOP command" for transition from Normal to Stop state)
		Updated <u>Figure 21, PCB Layout Recommendations</u> , comment NC Pin used for signal routing
		Updated Table 15, Component Value Recommendation
		Corrected Figure 23, Device on Thermal Test Board
		Removed reference to Note 11, Voltage Regulator - Dropout Voltage
		Added comment "LIN in recessive state" to Supply Current Range in Stop Mode and Sleep Mode
		Updated format to match current data sheet standard.
		Added Figure 10, Power On Reset and Normal Request Timeout Timing
		Added LIN P/L details
		 Made clarifications on Max Ratings Table for T_A and T_J Thermal Ratings and the accompanying Note
8.0	3/2007	Removed "Advance Information" watermark from first page.
9.0	9/2010	Changed Peak Package Reflow Temperature During Reflow ⁽³⁾⁽⁵⁾ description.
		Added note ⁽⁵⁾
10.0	8/2011	Deleted MM908E624ACDWB/R2
		Added MM908E624ACPEW/R2 and MM908E624AYPEW/R2
		Update Freescale form and style.
		Updated package drawing
11.0	4/2012	Removed part number MM908E624ACEW/ R2 and MM908E624AYEW/ R2.
		Update Freescale form and style.